

MRT Technology (Suzhou) Co., Ltd Phone: +86-512-66308358

Web: www.mrt-cert.com

Report No.: 1712RSU03309 Report Version: V01 Issue Date: 01-19-2018

## **MEASUREMENT REPORT**

# FCC PART 15.247 / RSS-247 Bluetooth

FCC ID : HD5-EDA60K0

IC : 1693B-EDA60K0

APPLICANT : Honeywell International Inc

Honeywell Sensing & Productivity Solutions

**Application Type** : Certification

**Product** : Mobile Computer

Model No. : EDA60K-0

Brand Name : Honeywell

FCC Classification : FCC Part 15 Spread Spectrum Transmitter(DSS)

FCC Rule Part(s) : Part 15 Subpart C (Section 15.247)

IC Rule(s): : RSS-247 Issue 2, RSS-GEN Issue 4

Test Procedure(s) : ANSI C63.10-2013

**Test Date** : December 15, 2017 ~ January 15, 2018

Reviewed By : Jame guan

( Jame Yuan )

Approved By : Marlinchen

(Marlin Chen)





The test results relate only to the samples tested.

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in ANSI C63.10-2013. Test results reported herein relate only to the item(s) tested.

The test report shall not be reproduced except in full without the written approval of MRT Technology (Suzhou) Co., Ltd.

FCC ID: HD5-EDA60K0 IC: 1693B-EDA60K0

Page Number: 1 of 103



Report No.: 1712RSU03309

# **Revision History**

Report No.	Version	sion Description Is		Note
1712RSU03309	Rev. 01	Initial report	01-19-2018	Valid

FCC ID: HD5-EDA60K0 Page Number: 2 of 103



# **CONTENTS**

De	scriptio	on	Page
1.	INTR	ODUCTION	7
	1.1.	Scope	7
	1.2.	MRT Test Location	7
2.	PROI	DUCT INFORMATION	8
	2.1.	Feature of Equipment under Test	8
	2.2.	Product Specification Subjective to this Report	
	2.3.	Operation Frequency / Channel List	10
	2.4.	Pseudorandom Frequency Hopping Sequence	11
	2.5.	Device Capabilities	11
	2.6.	Test Configuration	11
	2.7.	Test Software	12
	2.8.	EMI Suppression Device(s)/Modifications	12
	2.9.	Labeling Requirements	12
3.	DESC	CRIPTION of TEST	13
	3.1.	Evaluation Procedure	13
	3.2.	AC Line Conducted Emissions	
	3.3.	Radiated Emissions	14
4.	ANTE	ENNA REQUIREMENTS	15
5.	TEST	EQUIPMENT CALIBRATION DATE	16
6.	MEAS	SUREMENT UNCERTAINTY	17
7.	TEST	TRESULT	18
	7.1.	Summary	18
	7.2.	20dB Bandwidth Measurement	
	7.2.1.		
	7.2.2.		
	7.2.3.		
	7.2.4.		
	7.2.5.	·	
	7.3.	Output Power Measurement	24
	7.3.1.	•	
	7.3.2.	Test Procedure Used	24
	7.3.3.	Test Setting	24
	7.3.4.	Test Setup	24



7.3.5.	Test Result	25
7.4.	Carrier Frequency Separation Measurement	29
7.4.1.	Test Limit	29
7.4.2.	Test Procedure Used	29
7.4.3.	Test Setting	29
7.4.4.	Test Setup	29
7.4.5.	Test Result	30
7.5.	Number of Hopping Channels Measurement	34
7.5.1.	Test Limit	34
7.5.2.	Test Procedure Used	34
7.5.3.	Test Settitng	34
7.5.4.	Test Setup	34
7.5.5.	Test Result	35
7.6.	Time of Occupancy Measurement	38
7.6.1.	Test Limit	38
7.6.2.	Test Procedure Used	38
7.6.3.	Test Settitng	38
7.6.4.	Test Setup	39
7.6.5.	Test Result	40
7.7.	Band-edge Compliance Measurement	44
7.7.1.	To ad I limit	11
7.7.1.	Test Limit	44
7.7.2.	Test Procedure Used	
		44
7.7.2.	Test Procedure Used	44 44
7.7.2. 7.7.3.	Test Procedure Used Test Setting	44 44 45
7.7.2. 7.7.3. 7.7.4.	Test Procedure Used  Test Setting  Test Setup	44 44 45 46
7.7.2. 7.7.3. 7.7.4. 7.7.5.	Test Procedure Used  Test Setting  Test Setup  Test Result	44 44 45 46 50
7.7.2. 7.7.3. 7.7.4. 7.7.5. 7.8.	Test Procedure Used  Test Setting  Test Setup  Test Result  Conducted Spurious Emissions Measurement	44 45 46 50 50
7.7.2. 7.7.3. 7.7.4. 7.7.5. 7.8. 7.8.1.	Test Procedure Used Test Setting Test Setup Test Result Conducted Spurious Emissions Measurement Test Limit	44 45 46 50 50
7.7.2. 7.7.3. 7.7.4. 7.7.5. 7.8. 7.8.1. 7.8.2.	Test Procedure Used Test Setting Test Setup Test Result Conducted Spurious Emissions Measurement Test Limit Test Procedure Used	44 45 46 50 50 50
7.7.2. 7.7.3. 7.7.4. 7.7.5. 7.8. 7.8.1. 7.8.2. 7.8.3.	Test Procedure Used	44 44 45 46 50 50 50 50
7.7.2. 7.7.3. 7.7.4. 7.7.5. 7.8. 7.8.1. 7.8.2. 7.8.3. 7.8.4.	Test Procedure Used Test Setting Test Setup Test Result Conducted Spurious Emissions Measurement Test Limit Test Procedure Used Test Setting Test Setup	44 44 45 46 50 50 50 50 51
7.7.2. 7.7.3. 7.7.4. 7.7.5. 7.8. 7.8.1. 7.8.2. 7.8.3. 7.8.4. 7.8.5.	Test Procedure Used Test Setting Test Setup Test Result Conducted Spurious Emissions Measurement Test Limit Test Procedure Used Test Setting Test Setup Test Result	44 45 46 50 50 50 51 52 56
7.7.2. 7.7.3. 7.7.4. 7.7.5. 7.8.1. 7.8.2. 7.8.3. 7.8.4. 7.8.5. 7.9.	Test Procedure Used Test Setting Test Setup Test Result  Conducted Spurious Emissions Measurement Test Limit Test Procedure Used Test Setting Test Settup Test Result  Radiated Spurious Emission Measurement	44 45 46 50 50 50 51 52 56 56
7.7.2. 7.7.3. 7.7.4. 7.7.5. 7.8.1. 7.8.2. 7.8.3. 7.8.4. 7.8.5. 7.9.	Test Procedure Used Test Setting Test Setup  Test Result  Conducted Spurious Emissions Measurement  Test Limit  Test Procedure Used  Test Setting  Test Setup  Test Result  Radiated Spurious Emission Measurement  Test Limit	44 45 46 50 50 50 51 52 56 56
7.7.2. 7.7.3. 7.7.4. 7.7.5. 7.8.1. 7.8.2. 7.8.3. 7.8.4. 7.8.5. 7.9. 7.9.1.	Test Procedure Used Test Setting	44 45 46 50 50 50 51 52 56 56 56
7.7.2. 7.7.3. 7.7.4. 7.7.5. 7.8.1. 7.8.2. 7.8.3. 7.8.4. 7.9. 7.9.1. 7.9.2. 7.9.3.	Test Procedure Used Test Setting Test Setup Test Result  Conducted Spurious Emissions Measurement Test Limit Test Procedure Used Test Setting Test Setup Test Result  Radiated Spurious Emission Measurement Test Limit Test Procedure Used Test Result  Radiated Spurious Emission Measurement Test Limit Test Procedure Used Test Setting	44 45 46 50 50 50 51 52 56 56 56 56





8	CONCI	USION	103
	7.11.3.	Test Result	101
		Test Setup	
	7.11.1.	Test Limit	100
	7.11. A	AC Conducted Emissions Measurement	100
	7.10.5.	Test Result	76
		Test Setup	
	7.10.3.	Test Setting	74
	7.10.2.	Test Procedure Used	74
	7.10.1.	Test Limit	71



## §2.1033 General Information

Applicant:	Honeywell International Inc					
	Honeywell Sensing & Productivity Solutions					
Applicant Address:	9680 Old Bailes Road, Fort Mill, SC 29707 United States					
Manufacturer:	Honeywell International Inc					
	Honeywell Sensing & Productivity Solutions					
Manufacturer Address:	9680 Old Bailes Road, Fort Mill, SC 29707 United States					
Test Site:	MRT Technology (Suzhou) Co., Ltd					
Test Site Address:	D8 Building, No.2 Tian'edang Rd., Wuzhong Economic					
	Development Zone, Suzhou, China					
FCC Registration No.:	893164					
IC Registration No.:	11384A-1					
Test Device Serial No.:	N/A ☐ Production ☐ Pre-Production ☐ Engineering					
FCC Classification:	Spread Spectrum Transmitter(DSS)					

#### **Test Facility / Accreditations**

Measurements were performed at MRT Laboratory located in Tian'edang Rd., Suzhou, China.

- MRT facility is a FCC registered (MRT Reg. No. 893164) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules.
- MRT facility is an IC registered (MRT Reg. No. 11384A-1) test laboratory with the site description on file at Industry Canada.
- MRT facility is a VCCI registered (R-20025, G-20034, C-20020, T-20020) test laboratory with the site description on file at VCCI Council.
- MRT Lab is accredited to ISO 17025 by the American Association for Laboratory Accreditation (A2LA) under the American Association for Laboratory Accreditation Program (A2LA Cert. No. 3628.01) in EMC, Telecommunications and Radio testing for FCC, Industry Canada, EU and TELEC Rules.



FCC ID: HD5-EDA60K0 IC: 1693B-EDA60K0





#### 1. INTRODUCTION

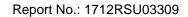
## 1.1. Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Industry Canada Certification and Engineering Bureau.

#### 1.2. MRT Test Location

The map below shows the location of the MRT LABORATORY, its proximity to the Taihu Lake. These measurement tests were conducted at the MRT Technology (Suzhou) Co., Ltd. Facility located at D8 Building, No.2 Tian'edang Rd., Wuzhong Economic Development Zone, Suzhou, China. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4-2009 on September 30, 2013.







# 2. PRODUCT INFORMATION

## 2.1. Feature of Equipment under Test

Product Name	Mobile Computer				
Model No.	EDA60K-0				
HW Version	SNB743_MB_V1.02_PCB				
SW Version	206.01.00.0011				
Wi-Fi Specification	802.11a/b/g/n/ac				
Bluetooth Version	v4.1 dual mode				
Accessories					
	Model No.: ADS-12B-06 05010E				
Adapter	Input Power: 100 - 240V ~ 50/60Hz, Max. 0.3A				
	Output Power: 5VDC 2.0A				
	Model No.: EDA60K-HB				
Home Base	Input Power: 12V DC 3.0A				
	Output Power: 5VDC 1.2A				
	Model No.: ADS-65LSI-12-1 12036E				
Home Base Adapter	Input Power: 100 - 240V ~ 50/60Hz, 1.5A Max.				
	Output Power: 12VDC 3.0A				
Code Scanner #1	Model No.: N4313				
Code Scanner #2	Model No.: N5603				
	Model No.: AB17				
Pottory 1#	Capacitance: 7.4Wh, 2Ah				
Battery 1#	Rated Voltage: 3.7V				
	Limit Charge Voltage: 4.22V				
	Model No.: AB18				
Battery 2#	Capacitance: 18.9Wh, 5.1Ah				
Dattery 2#	Rated Voltage: 3.7V				
	Limit Charge Voltage: 4.22V				





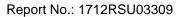
## 2.2. Product Specification Subjective to this Report

Operating Frequency	2402~2480MHz
Type of modulation	FHSS
Data Rate	1Mbps(GFSK), 2Mbps(Pi/4 DQPSK), 3Mbps (8DPSK)
Antenna Type	FPC Antenna
Antenna Gain	1.04dBi

Note: For other features of this EUT, test report will be issued separately.

- 15.247(g): In accordance with the Bluetooth Industry Standard, the system is designed to comply with all of the regulations in Section 15.247 when the transmitter is presented with a continuous data (or information) system.
- 15.247(h): In accordance with the Bluetooth Industry Standard, the system does not coordinate
  its channels selection/ hopping sequence with other frequency hopping systems for the express
  purpose of avoiding the simultaneous occupancy of individual hopping frequencies by multiple
  transmitters.
- 15.247(h): The EUT employs Adaptive Frequency Hopping (AFH) which identifies sources of interference namely devices operating in 802.11 WLAN and excludes them from the list of available channels. The process of re-mapping reduces the number of test channels from 79 channels to a minimum number of 20 channels.

FCC ID: HD5-EDA60K0 IC: 1693B-EDA60K0

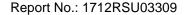


Page Number: 10 of 103



# 2.3. Operation Frequency / Channel List

Channel	Frequency	Channel	Frequency	Channel	Frequency
00	2402 MHz	01	2403 MHz	02	2404 MHz
03	2405 MHz	04	2406 MHz	05	2407 MHz
06	2408 MHz	07	2409 MHz	08	2410 MHz
09	2411 MHz	10	2412 MHz	11	2413 MHz
12	2414 MHz	13	2415 MHz	14	2416 MHz
15	2417 MHz	16	2418 MHz	17	2419 MHz
18	2420 MHz	19	2421 MHz	20	2422 MHz
21	2423 MHz	22	2424 MHz	23	2425 MHz
24	2426 MHz	25	2427 MHz	26	2428 MHz
27	2429 MHz	28	2430 MHz	29	2431 MHz
30	2432 MHz	31	2433 MHz	32	2434 MHz
33	2435 MHz	34	2436 MHz	35	2437 MHz
36	2438 MHz	37	2439 MHz	38	2440 MHz
39	2441 MHz	40	2442 MHz	41	2443 MHz
42	2444 MHz	43	2445 MHz	44	2446 MHz
45	2447 MHz	46	2448 MHz	47	2449 MHz
48	2450 MHz	49	2451 MHz	50	2452 MHz
51	2453 MHz	52	2454 MHz	53	2455 MHz
54	2456 MHz	55	2457 MHz	56	2458 MHz
57	2459 MHz	58	2460 MHz	59	2461 MHz
60	2462 MHz	61	2463 MHz	62	2464 MHz
63	2465 MHz	64	2466 MHz	65	2467 MHz
66	2468 MHz	67	2469 MHz	68	2470 MHz
69	2471 MHz	70	2472 MHz	71	2473 MHz
72	2474 MHz	73	2475 MHz	74	2476 MHz
75	2477 MHz	76	2478 MHz	77	2479 MHz
78	2480 MHz				

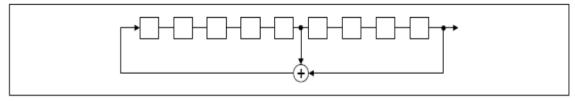




## 2.4. Pseudorandom Frequency Hopping Sequence

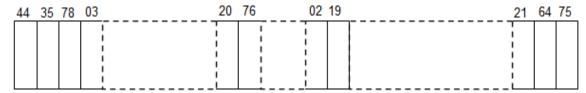
The pseudorandom sequence may be generated in a nine-stage shift register whose 5th and 9<sup>th</sup> stage outputs are added in a modulo-two addition stage. And the result is fed back to the input of the first stage. The sequence begins with the first ONE of 9 consecutive ONEs; i.e. the shift register is initialized with nine ones.

- Number of shift register stages: 9
- Length of pseudo-random sequence: 29 1 = 511 bits
- Longest sequence of zeros: 8 (non-inverted signal)



Linear Feedback Shift Register for Generation of the PRBS sequence

An example of Pseudorandom Frequency Hopping Sequence as follow:



Each frequency used equally on the average by each transmitter.

The system receivers have input bandwidths that match the hopping channel bandwidths of their Corresponding transmitters and shift frequencies in synchronization with the transmitted signals.

## 2.5. Device Capabilities

5GHz WLAN (UNII), 2.4GHz WLAN (DTS), Bluetooth (v4.1 dual mode)

#### 2.6. Test Configuration

The device was tested per the guidance of ANSI C63.10-2013. ANSI C63.10-2013 was used to reference the appropriate EUT setup for radiated spurious emissions testing and AC line conducted testing.

FCC ID: HD5-EDA60K0 IC: 1693B-EDA60K0



#### 2.7. Test Software

The test utility software used during testing was "QRCT".

Power Parameter Value

Test Mode	Test Channel No.	Test Frequency	Power Parameter Value	
		(MHz)		
	00	2402	9	
DH5	39	2441	9	
	78	2480	9	
	00	2402	9	
2DH5	39	2441	9	
	78	2480	9	
	00	2402	9	
3DH5	39	2441	9	
	78	2480	9	

## 2.8. EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and/or no modifications were made during testing.

#### 2.9. Labeling Requirements

#### Per 2.1074 & 15.19; Docket 95-19

The label shall be permanently affixed at a conspicuous location on the device; instruction manual or pamphlet supplied to the user and be readily visible to the purchaser at the time of purchase.

However, when the device is so small wherein placement of the label with specified statement is not practical, only the FCC ID must be displayed on the device per Section 15.19(a)(5). Please see attachment for FCC ID label and label location.

#### RSP-100 Issue 11 Section 3

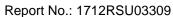
The manufacturer, importer or distributor shall meet the labelling requirements set out in this section for every unit:

- (i) prior to marketing in Canada, for products manufactured in Canada
- (ii) prior to importation into Canada, for imported products

For information regarding the e-labelling option, see Notice 2014-DRS1003. The label for the certified product represents the manufacturer's or importer's compliance with Innovation, Science and Economic Development Canada's (ISED) regulatory requirements.

Please see attachment for IC label and label location.

FCC ID: HD5-EDA60K0 Page Number: 12 of 103





#### 3. DESCRIPTION of TEST

#### 3.1. Evaluation Procedure

The measurement procedures described in the American National Standard for Testing Unlicensed Wireless Devices (ANSI C63.10-2013), and the "Filing and Measurement Guidelines for Frequency Hopping Spread Spectrum Systems" (DA 00-705) were used in the measurement.

Deviation from measurement procedure......None

#### 3.2. AC Line Conducted Emissions

The line-conducted facility is located inside an 8'x4'x4' shielded enclosure. A 1m x 2m wooden table 80cm high is placed 40cm away from the vertical wall and 80cm away from the sidewall of the shielded room. Two 10kHz-30MHz,  $50\Omega/50$ uH Line-Impedance Stabilization Networks (LISNs) are bonded to the shielded room floor. Power to the LISNs is filtered by external high-current high-insertion loss power line filters. These filters attenuate ambient signal noise from entering the measurement lines. These filters are also bonded to the shielded enclosure.

The EUT is powered from one LISN and the support equipment is powered from the second LISN. All interconnecting cables more than 1 meter were shortened to a 1 meter length by non-inductive bundling (serpentine fashion) and draped over the back edge of the test table. All cables were at least 40cm above the horizontal reference ground-plane. Power cables for support equipment were routed down to the second LISN while ensuring that that cables were not draped over the second LISN.

Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The RF output of the LISN was connected to the receiver and exploratory measurements were made to determine the frequencies producing the maximum emission from the EUT. The receiver was scanned from 150kHz to 30MHz. The detector function was set to peak mode for exploratory measurements while the bandwidth of the analyzer was set to 9kHz. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Each emission was also maximized by varying: power lines, the mode of operation or data exchange speed, or support equipment whichever determined the worst-case emission. Once the worst case emissions have been identified, the one EUT cable configuration/arrangement and mode of operation that produced these emissions were used for final measurements on the same test site. The analyzer is set to CISPR quasi-peak and average detectors with a 9kHz resolution bandwidth for final measurements.

An extension cord was used to connect to a single LISN which powered by EUT. The extension cord was calibrated with LISN, the impedance and insertion loss are compliance with the requirements as stated in ANSI C63.10-2013.

FCC ID: HD5-EDA60K0 Page Number: 13 of 103



#### 3.3. Radiated Emissions

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. For measurements above 1GHz absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections. For measurements below 1GHz, the absorbers are removed. An MF Model 210SS turntable is used for radiated measurement. It is a continuously rotatable, remote controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. An 80cm high PVC support structure is placed on top of the turntable. For all measurements, the spectrum was scanned through all EUT azimuths and from 1 to 4 meter receive antenna height using a broadband antenna from 30MHz up to the upper frequency shown in 15.33(b)(1) depending on the highest frequency generated or used in the device or on which the device operates or tunes. For frequencies above 1GHz, linearly polarized double ridge horn antennas were used. For frequencies below 30MHz, a calibrated loop antenna was used. When exploratory measurements were necessary, they were performed at 1 meter test distance inside the semi-anechoic chamber using broadband antennas, broadband amplifiers, and spectrum analyzers to determine the frequencies and modes producing the maximum emissions. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The test set-up for frequencies below 1GHz was placed on top of the 0.8 meter high, 1 x 1.5 meter table; and test set-up for frequencies 1-40GHz was placed on top of the 1.5 meter high, 1 x 1.5 meter table. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Appropriate precaution was taken to ensure that all emissions from the EUT were maximized and investigated. The system configuration, clock speed, mode of operation or video resolution, if applicable, turntable azimuth, and receive antenna height was noted for each frequency found.

Final measurements were made in the semi-anechoic chamber using calibrated, linearly polarized broadband and horn antennas. The test setup was configured to the setup that produced the worst case emissions. The spectrum analyzer was set to investigate all frequencies required for testing to compare the highest radiated disturbances with respect to the specified limits. The turntable containing the EUT was rotated through 360 degrees and the height of the receive antenna was varied 1 to 4 meters and stopped at the azimuth and height producing the maximum emission. Each emission was maximized by changing the orientation of the EUT through three orthogonal planes and changing the polarity of the receive antenna, whichever produced the worst-case emissions. According to 3dB Beamwidth of horn antenna, the horn antenna should be always directed to the EUT when rising height.

FCC ID: HD5-EDA60K0 Page Number: 14 of 103 IC: 1693B-EDA60K0





## 4. ANTENNA REQUIREMENTS

#### Excerpt from §15.203 of the FCC Rules/Regulations:

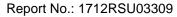
"An intentional radiator antenna shall be designed to ensure that no antenna other than that furnished by the responsible party can be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section."

- The antenna of the **Mobile Computer** is **permanently attached**.
- There are no provisions for connection to an external antenna.

#### Conclusion:

The unit complies with the requirement of §15.203.

FCC ID: HD5-EDA60K0 Page Number: 15 of 103





## 5. TEST EQUIPMENT CALIBRATION DATE

## Conducted Emissions - SR2

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
EMI Test Receiver	R&S	ESR7	MRTSUE06001	1 year	2018/08/18
Two-Line V-Network	R&S	ENV 216	MRTSUE06002	1 year	2018/06/21
Two-Line V-Network	R&S	ENV 216	MRTSUE06003	1 year	2018/06/21
Thermohygrometer	Testo	608-H1	MRTSUE06404	1 year	2018/08/14
Shielding Anechoic Chamber	Mikebang	Chamber-SR2	MRTSUE06215	N/A	N/A

## Radiated Emission - AC2

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
MXE EMI Receiver	Agilent	N9038A	MRTSUE06125	1 year	2018/08/18
EXA Signal Analyzer	Agilent	N9010A	MRTSUE06195	1 year	2018/04/22
Loop Antenna	Schwarzbeck	FMZB 1519	MRTSUE06025	1 year	2018/11/20
Bilog Period Antenna	Schwarzbeck	VULB 9162	MRTSUE06022	1 year	2018/10/21
Broad Band Horn Antenna	Schwarzbeck	BBHA 9120D	MRTSUE06171	1 year	2018/11/18
Broadband Coaxial Preamplifier	Schwarzbeck	BBV 9718	MRTSUE06176	1 year	2018/11/17
Digitial Thermometer & Hygrometer	MingGao	ETH529	MRTSUE06170	1 year	2018/12/12
Anechoic Chamber	RIKEN	Chamber-AC2	MRTSUE06213	1 year	2018/05/09

## Conducted Test Equipment - TR3

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
Power Meter	Agilent	U2021XA	MRTSUE06030	1 year	2018/12/06
Temperature Humidity Chamber	ВАОҮТ	BYH-150CL	MRTSUE06051	1 year	2018/12/06
EXA Signal Analyzer	Agilent	N9020A	MRTSUE06106	1 year	2018/04/25
Thermohygrometer	Testo	608-H1	MRTSUE06401	1 year	2018/08/14

Software	Version	Function
e3	V8.3.5	EMI Test Software

FCC ID: HD5-EDA60K0 Page Number: 16 of 103

IC: 1693B-EDA60K0





#### MEASUREMENT UNCERTAINTY 6.

Where relevant, the following test uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k = 2.

#### AC Conducted Emission Measurement - SR2

Measuring Uncertainty for a Level of Confidence of 95% (U=2Uc(y)):

150kHz~30MHz: 3.46dB

#### Radiated Emission Measurement - AC1

Measuring Uncertainty for a Level of Confidence of 95% (U=2Uc(y)):

9kHz ~ 1GHz: 4.18dB 1GHz ~ 25GHz: 4.76dB

#### Spurious Emissions, Conducted - SR1

Measuring Uncertainty for a Level of Confidence of 95% (U=2Uc(y)):

0.78dB

## Output Power - SR1

Measuring Uncertainty for a Level of Confidence of 95% (U=2Uc(y)):

1.13dB

## Occupied Bandwidth - SR1

Measuring Uncertainty for a Level of Confidence of 95% (U=2Uc(y)):

0.28%

FCC ID: HD5-EDA60K0 Page Number: 17 of 103 IC: 1693B-EDA60K0



Report No.: 1712RSU03309

## 7. TEST RESULT

## 7.1. Summary

Company Name: Honeywell International Inc

**Honeywell Sensing & Productivity Solutions** 

FCC ID: <u>HD5-EDA60K0</u>
IC: <u>1693B-EDA60K0</u>

FCC Part Section(s)	IC Section(s)	Test Description	Test Limit	Test Condition	Test Result	Reference
15.247(a)(1)	RSS-247 [5.1]	20dB Bandwidth	N/A		PASS	Section 7.2
15.247(b)(1)	RSS-247 [5.4(b)]	Peak Transmitter Output Power	<1 Watt if > 75 non- overlapping channels used		PASS	Section 7.3
15.247(a)(1)	RSS-247 [5.1]	Channel Separation	> 2/3 of 20 dB BW for systems with Output Power < 125mW	PASS Conducted		Section 7.4
15.247(a)(1) (iii)	RSS-247 [5.1]	Number of Channels	> 15 Channels		PASS	Section 7.5
15.247(a)(1) (iii)	RSS-247 [5.1]	Time of Occupancy	< 0.4 sec in 31.6 sec period		PASS	Section 7.6
15.247(d)	RSS-247 [5.5]	Band Edge / out- of-Band Emissions	Conducted ≥ 20dBc		PASS	Section 7.7 Section 7.8
15.205, 15.209	RSS-247 [5.5]	General Field Strength Limits (Restricted Bands and Radiated Emission Limits)	Emissions in restricted bands must meet the radiated limits detailed in 15.209	Radiated	PASS	Section 7.9 Section 7.10
15.207	RSS-Gen [8.8]	AC Conducted Emissions 150kHz - 30MHz	< FCC 15.207 limits	Line Conducted	Pass	Section 7.11

#### Notes:

- 1) All channels, modes, and modulations/data rates were investigated among all UNII bands. For radiated emission test, every axis (X, Y, Z) was also verified. The test results shown in the following sections represent the worst case emissions.
- 2) The analyzer plots shown in this section were all taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables and attenuators used as part of the system to connect the EUT to the analyzer at all frequencies of interest.

FCC ID: HD5-EDA60K0 Page Number: 18 of 103

IC: 1693B-EDA60K0



#### 7.2. 20dB Bandwidth Measurement

#### 7.2.1.Test Limit

N/A

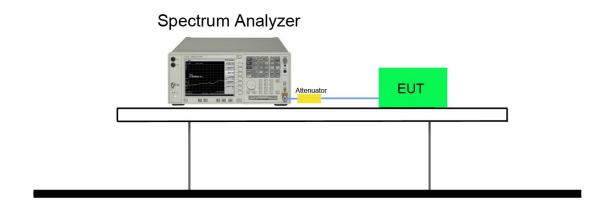
#### 7.2.2.Test Procedure used

ANSI C63.10-2013 - Section 6.9.2

## 7.2.3.Test Setting

- 1. Set RBW ≥ 1 ~ 5% of the OBW
- 2. VBW  $\geq$  3 × RBW
- 3. Span = approximately 2 to 5 times the OBW, center frequency is set to the nominal EUT channel center frequency
- 4. Detector = Peak
- 5. Trace mode = Max hold
- 6. Sweep = auto couple
- 7. Allow the trace to stabilize
- 8. Measure the maximum width of the emission that is constrained by the frequencies associated with the two outermost amplitude points (upper and lower frequencies) that are attenuated by 20 dB relative to the maximum level measured in the fundamental emission.

## 7.2.4.Test Setup



FCC ID: HD5-EDA60K0 Page Number: 19 of 103

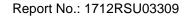




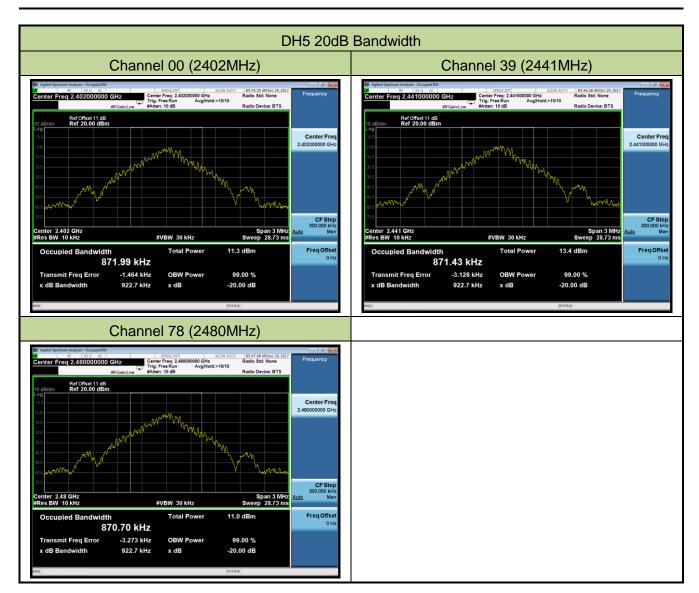
## 7.2.5.Test Result

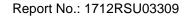
Product	Mobile Computer	Temperature	23°C
Test Engineer	Hunk Li	Relative Humidity	50%
Test Site	TR3	Test Date	2017/12/29

Test Mode	Channel No.	Frequency (MHz)	20dB Bandwidth (kHz)	Result
DH5	00	2402	922.7	Pass
DH5	39	2441	922.7	Pass
DH5	78	2480	922.7	Pass
2DH5	00	2402	1224	Pass
2DH5	39	2441	1224	Pass
2DH5	78	2480	1223	Pass
3DH5	00	2402	1252	Pass
3DH5	39	2441	1252	Pass
3DH5	78	2480	1251	Pass

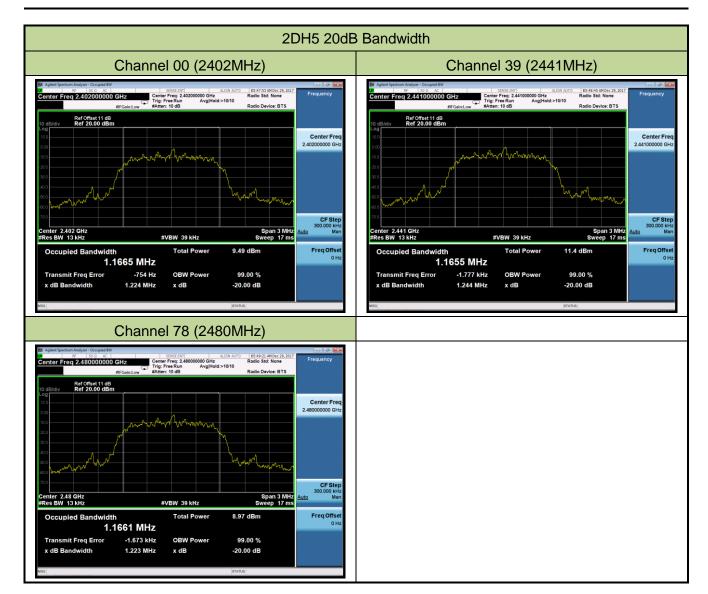


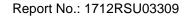




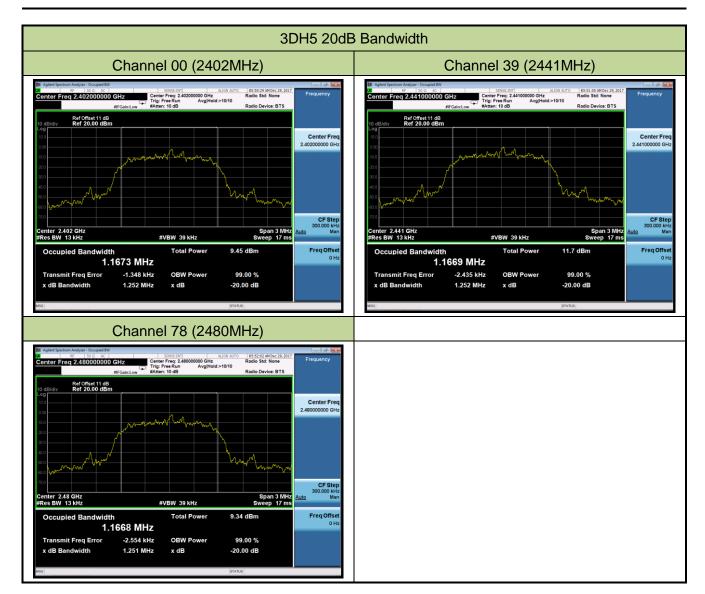














## 7.3. Output Power Measurement

#### 7.3.1.Test Limit

The maximum out power permissible output power is 1 Watt for all other frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels. The E.I.R.P shall not exceed 4 Watt.

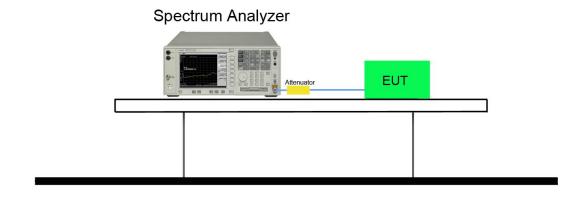
#### 7.3.2.Test Procedure Used

ANSI C63.10-2013 - Section 7.8.5

#### 7.3.3.Test Setting

- 1. Set RBW ≥ the 20 dB bandwidth of the emission being measured.
- 2. VBW ≥RBW
- 3. Span = approximately 2 to 3 times the 20dB bandwidth, centered on a hopping channel
- 4. Detector = Peak
- 5. Trace mode = Max hold
- 6. Sweep = auto couple
- 7. Allow the trace to stabilize, Use the marker-to-peak function to set the marker to the peak of the emission. The indicated level is the peak output power (don't forget added the external attenuation and cable loss)

#### 7.3.4.Test Setup



FCC ID: HD5-EDA60K0 Page Number: 24 of 103



Report No.: 1712RSU03309

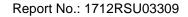
## 7.3.5.Test Result

Product	Mobile Computer	Temperature	23°C
Test Engineer	Hunk Li	Relative Humidity	50%
Test Site	TR3	Test Date	2017/12/29

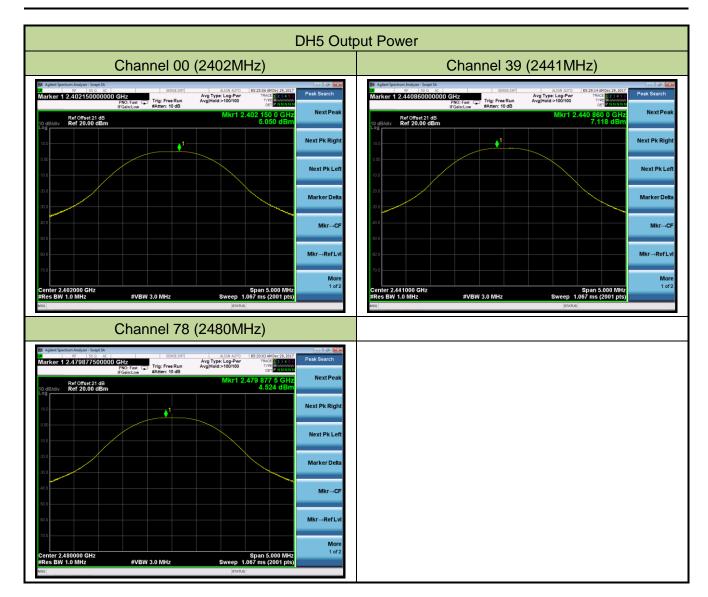
Test Mode	Channel No.	Frequency (MHz)	Peak Power (dBm)	Peak Power Limit (dBm)
DH5	00	2402	5.05	< 30
DH5	39	2441	7.12	< 30
DH5	78	2480	4.52	< 30
2DH5	00	2402	5.19	< 30
2DH5	39	2441	7.24	< 30
2DH5	78	2480	4.92	< 30
3DH5	00	2402	5.52	< 30
3DH5	39	2441	7.60	< 30
3DH5	78	2480	5.26	< 30

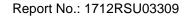
Note 1: EIRP (dBm) = Conducted Power (dBm) + Antenna Gain (dBi).

Note 2: Max EIRP (dBm) = 7.60 dBm + 1.04 dBi = 8.64 dBm < 36 dBm.



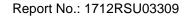




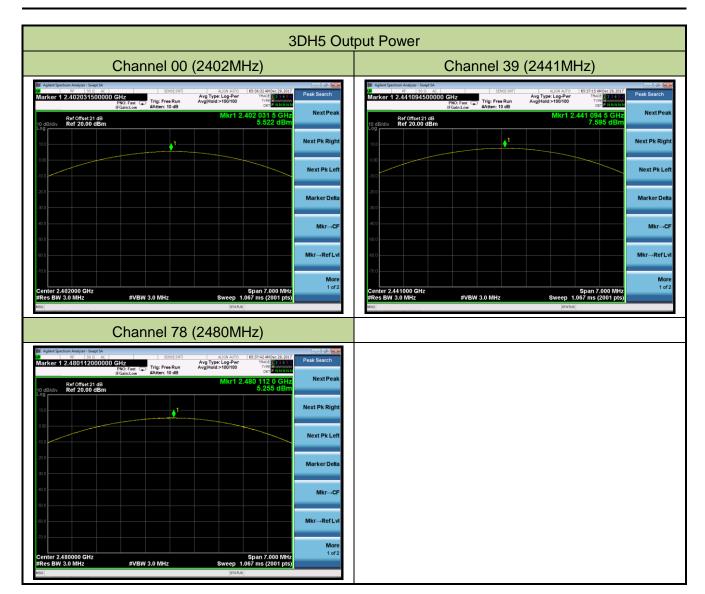


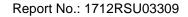














## 7.4. Carrier Frequency Separation Measurement

#### 7.4.1.Test Limit

The minimum permissible channel separation for this system is 2/3 the value of the 20dB BW.

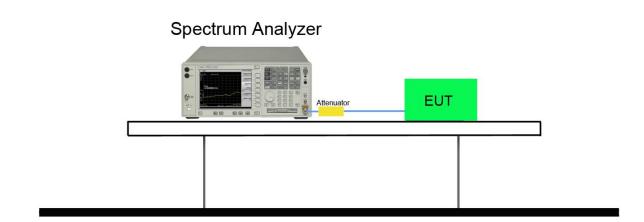
#### 7.4.2.Test Procedure Used

ANSI C63.10-2013 - Section 7.8.2

## 7.4.3.Test Setting

- 1. Span = wide enough to capture the peaks of two adjacent channels.
- 2. RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel.
- 3. VBW ≥ RBW
- 4. Sweep time = auto couple
- 5. Detector = Peak
- 6. Trace mode = Max hold
- 7. Trace was allowed to stabilize

## 7.4.4.Test Setup



FCC ID: HD5-EDA60K0 Page Number: 29 of 103

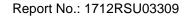




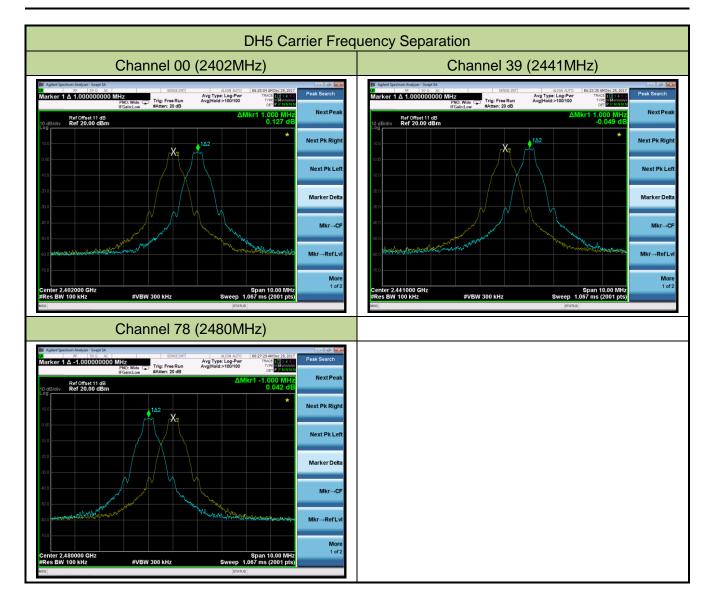
## 7.4.5.Test Result

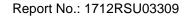
Product	Mobile Computer	Temperature	23°C
Test Engineer	Hunk Li	Relative Humidity	50%
Test Site	TR3	Test Date	2017/12/29

Test Mode	Channel No.	Frequency (MHz)	Limit (kHz)	Result
DH5	00	2402	≥ 615.13	Pass
DH5	39	2441	≥ 615.13	Pass
DH5	78	2480	≥ 615.13	Pass
2DH5	00	2402	≥ 816.00	Pass
2DH5	39	2441	≥ 816.00	Pass
2DH5	78	2480	≥ 815.33	Pass
3DH5	00	2402	≥ 834.67	Pass
3DH5	39	2441	≥ 834.67	Pass
3DH5	78	2480	≥ 834.00	Pass

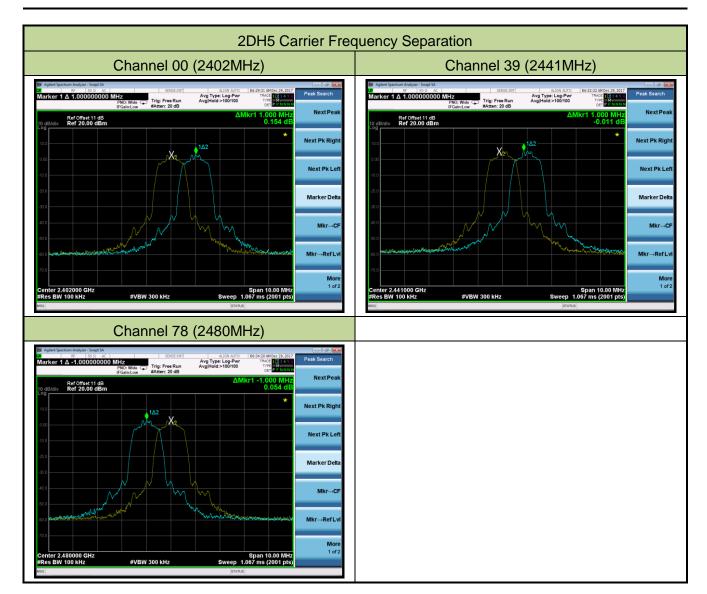


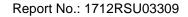




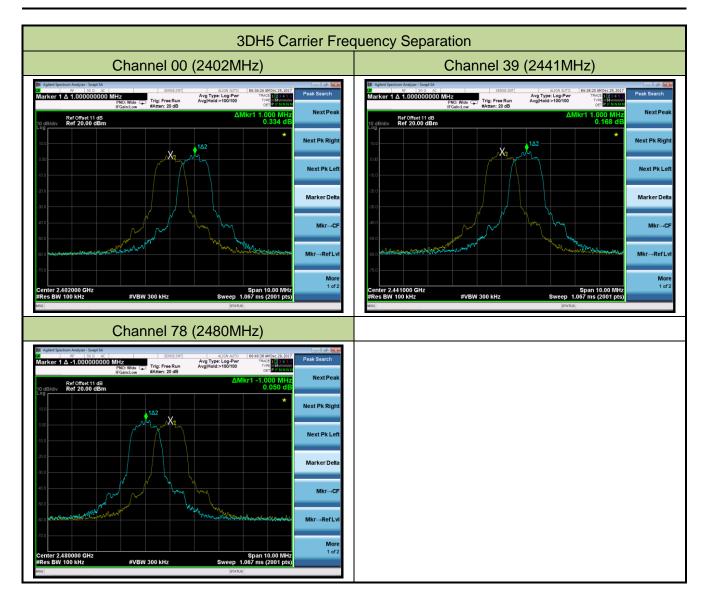














## 7.5. Number of Hopping Channels Measurement

#### 7.5.1.Test Limit

This frequency hopping system must employ a minimum of 15 hopping channels.

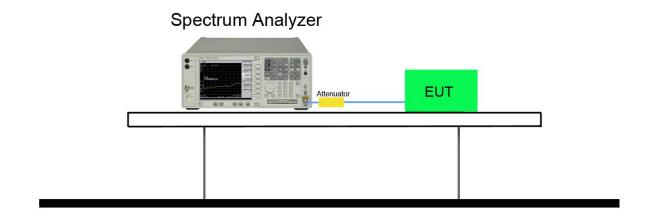
#### 7.5.2.Test Procedure Used

ANSI C63.10-2013 - Section 7.8.3

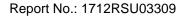
#### 7.5.3.Test Settitng

- 1. Span = the frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen.
- 2. RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller.
- 3. VBW ≥ RBW
- 4. Sweep time = auto couple
- 5. Detector = Peak
- 6. Trace mode = Max hold
- 7. The trace was allowed to stabilize

#### 7.5.4.Test Setup



FCC ID: HD5-EDA60K0 Page Number: 34 of 103

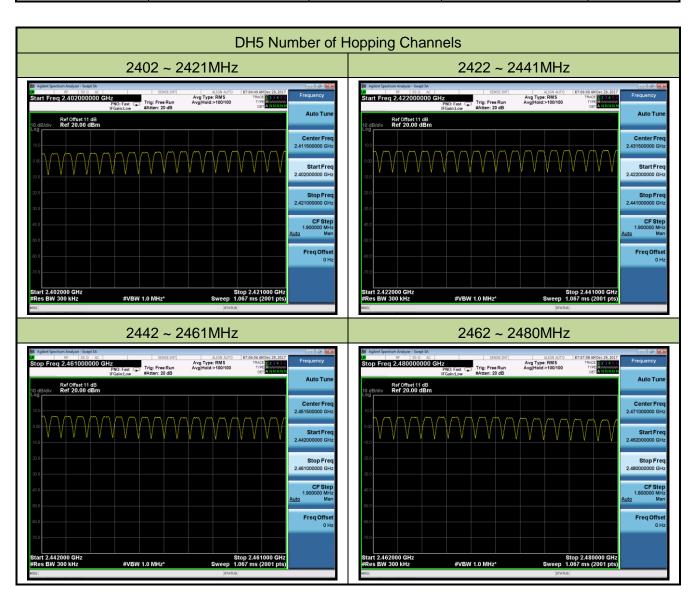


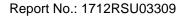


#### 7.5.5.Test Result

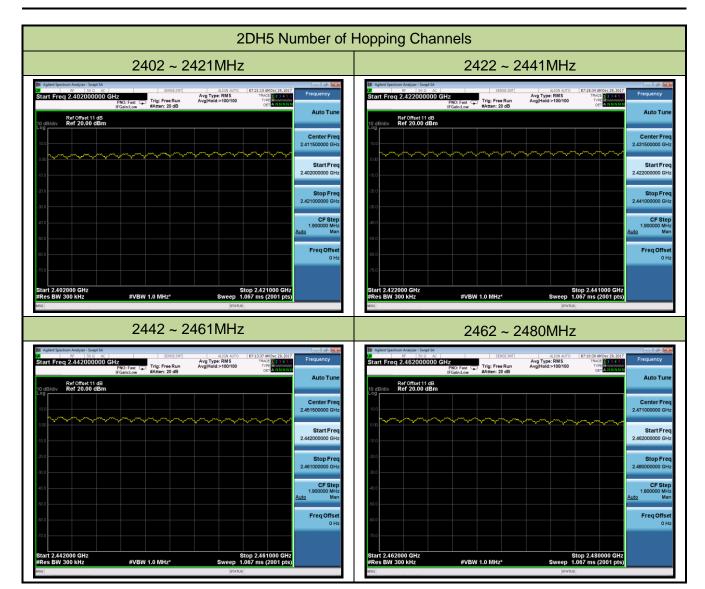
Product	Mobile Computer	Temperature	23°C
Test Engineer	Hunk Li	Relative Humidity	50%
Test Site	TR3	Test Date	2017/12/29

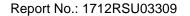
Test Mode (Hopping)	Channel Numbers	Frequency (MHz)	Limit (Hopping Channels)	Result
DH5	79	2402~2480	≥ 15	Pass
2DH5	79	2402~2480	≥ 15	Pass
3DH5	79	2402~2480	≥ 15	Pass



















## 7.6. Time of Occupancy Measurement

#### 7.6.1.Test Limit

The maximum permissible time of occupancy is 400ms within a period of 400ms multiplied by the number of hopping channels employed.

#### 7.6.2.Test Procedure Used

ANSI C63.10-2013 - Section 7.8.4

#### 7.6.3.Test Settitng

- 1. Span = zero span, centered on a hopping channel.
- RBW shall be ≤ channel spacing and where possible RBW should be set >> 1 / T, where T is the
  expected dwell time per channel.
- 3. VBW ≥ RBW
- 4. Sweep time = as necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel.
- 5. Detector = Peak
- 6. Trace mode = Max hold
- 7. If possible, use the marker-delta function to determine the dwell time. If this value varies with different modes of operation (data rate, modulation format, etc.), repeat this test for each variation. An oscilloscope may be used instead of a spectrum analyzer. The EUT shall show compliance with the appropriate regulatory limit for the number of hopping channels. A plot of the data shall be included in the test report.

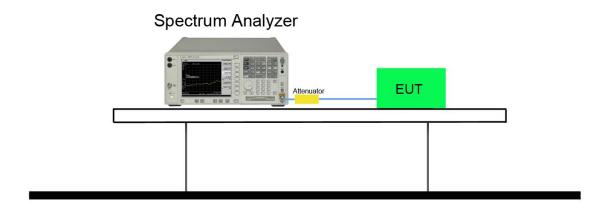
FCC ID: HD5-EDA60K0 Page Number: 38 of 103

IC: 1693B-EDA60K0





## 7.6.4.Test Setup







## 7.6.5.Test Result

Product	Mobile Computer	Temperature	23°C
Test Engineer	Hunk Li	Relative Humidity	50%
Test Site	TR3	Test Date	2017/12/29

Test Mode	Channel No.	Frequency (MHz)	Hops Over Occupancy Time(Hops)	Packet Transfer Time (ms)	Time of Occupancy (ms)	Limit (ms)	Result
DH1	39	2441	320	0.38	121.60	< 400	Pass
DH3	39	2441	160	1.64	262.40	< 400	Pass
DH5	39	2441	107	2.87	307.09	< 400	Pass
2DH1	39	2441	320	0.39	124.80	< 400	Pass
2DH3	39	2441	160	1.64	262.40	< 400	Pass
2DH5	39	2441	107	2.89	309.23	< 400	Pass
3DH1	39	2441	320	0.39	124.80	< 400	Pass
3DH3	39	2441	160	1.64	262.40	< 400	Pass
3DH5	39	2441	107	2.89	309.23	< 400	Pass

